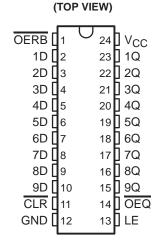
DW OR NT PACKAGE

SDAS028B - APRIL 1984 - REVISED JANUARY 1995

- 3-State I/O-Type Read-Back Inputs
- Bus-Structured Pinout
- True Logic Outputs
- Designed With Nine Bits for Parity Applications
- Package Options Include Plastic Small-Outline (DW) Packages and Standard Plastic (NT) 300-mil DIPs

### description

This 9-bit latch is designed specifically for storing the contents of the input data bus and providing the capability of reading back the stored data onto the input data bus. In addition, this device provides a 3-state buffer-type output and is easily implemented in parity applications.

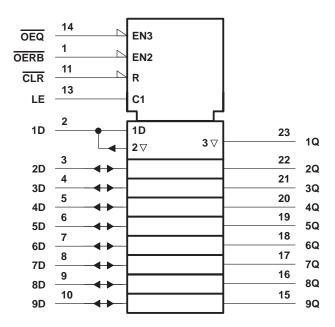


The nine latches are transparent D-type latches. While the latch-enable (LE) input is high, the Q outputs follow the data (D) inputs. The Q outputs are in the 3-state condition when the output-enable  $(\overline{OEQ})$  input is high.

Read back is provided through the output-enable (OERB) input. When OERB is taken low, the data present at the output of the data latches is allowed to pass back onto the input data bus. When OERB is taken high, the output of the data latches is isolated from the D inputs. OERB does not affect the internal operation of the latches; however, precautions should be taken not to create a bus conflict.

The SN74ALS992 is characterized for operation from 0°C to 70°C.

### logic symbol†

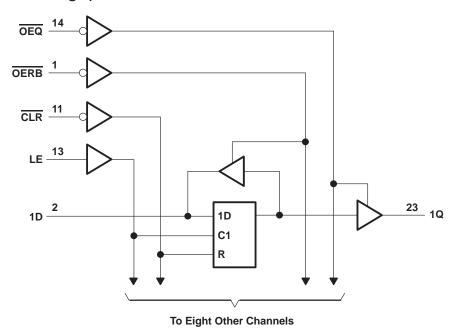


<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

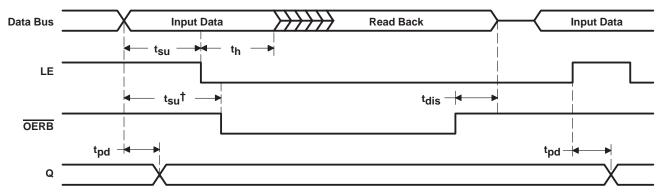


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### logic diagram (positive logic)



### timing diagram



 $\overline{\text{CLR}} = \text{H}, \overline{\text{OEQ}} = \text{L}$ 

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V <sub>CC</sub>	
Input voltage, V <sub>I</sub> (OERB, OEQ, CLR, and LE)	7 V
Voltage applied to D inputs and to disabled 3-state outputs	5.5 V
Operating free-air temperature range, T <sub>A</sub>	0°C to 70°C
Storage temperature range	-65°C to 150°C

<sup>‡</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.



<sup>&</sup>lt;sup>†</sup> This setup time ensures that the read-back circuit will not create a conflict on the input data bus.

### recommended operating conditions

			MIN	NOM	MAX	UNIT
Vcc	V <sub>CC</sub> Supply voltage					V
VIH	High-level input voltage		2			V
V <sub>IL</sub>	Low-level input voltage				0.8	V
la	High level output output	Q			-2.6	mA
IOH High-level output current		D			-0.4	IIIA
la.	Low lovel output ourrent	Q			24	mA
IOL	Low-level output current	D			8	IIIA
·	Pulse duration	LE high	10			no
t <sub>W</sub>	ruise duration	CLR low	10			ns
	Catua tima	Data before LE↓	10			
t <sub>su</sub>	t <sub>SU</sub> Setup time Data before		10			ns
th	Hold time, data after LE↓		5			ns
T <sub>A</sub> Operating free-air temperature			0		70	°C

### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER TES			DITIONS	MIN T	YP† N	VIAX	UNIT
٧ <sub>IK</sub>		$V_{CC} = 4.5 V,$	I <sub>I</sub> = -18 mA		-	-1.2	V
V	All outputs	outputs $V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}, \qquad I_{OH} = -0.4 \text{ mA}$		V <sub>CC</sub> -2			V
VOH	Q	$V_{CC} = 4.5 V,$	$I_{OH} = -2.6 \text{ mA}$	2.4	3.2		V
	D	V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 4 mA	(	0.25	0.4	
\/o.	В	∨CC = 4.5 v	$I_{OL} = 8 \text{ mA}$	(	0.35	0.5	V
VOL		Vac = 4.5.V	I <sub>OL</sub> = 12 mA	(	0.25	0.4	v
	Q V <sub>CC</sub> = 4.5 V		I <sub>OL</sub> = 24 mA	(	0.35	0.5	
lozh	Q	$V_{CC} = 5.5 V,$	$V_0 = 2.7 \text{ V}$			20	μΑ
lozL	Q	$V_{CC} = 5.5 V,$	V <sub>O</sub> = 0.4 V			-20	μΑ
1.	D inputs	V 55V	V <sub>I</sub> = 5.5 V			0.1	mA
ΙΙ	All others	V <sub>CC</sub> = 5.5 V	V <sub>I</sub> = 7 V			0.1	IIIA
	D inputs‡	V F V	V. 27V			20	^
lн	All others	V <sub>CC</sub> = 5.5 V,	$V_{I} = 2.7 \text{ V}$			20	μΑ
	D inputs‡	V 55V	V <sub>1</sub> 0.4 V		-	-0.1	A
IIL.	All others	V <sub>CC</sub> = 5.5 V,	$V_{I} = 0.4 V$		-	-0.1	mA
IO§		V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.25 V	-30	-	-112	mA
		V 55V	Outputs high		30	50	
ICC		<u>V<sub>CC</sub> =</u> 5.5 V, OERB high	Outputs low		50	80	mA
			Outputs disabled		35	55	



<sup>†</sup> All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C. ‡ For I/O ports (Q<sub>A</sub> thru Q<sub>H</sub>), the parameters I<sub>IH</sub> and I<sub>IL</sub> include the off-state output current. § The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I<sub>OS</sub>.

# **SN74ALS992** 9-BIT D-TYPE TRANSPARENT READ-BACK LATCH WITH 3-STATE OUTPUTS SDAS028B – APRIL 1984 – REVISED JANUARY 1995

# switching characteristics (see Figure 1)

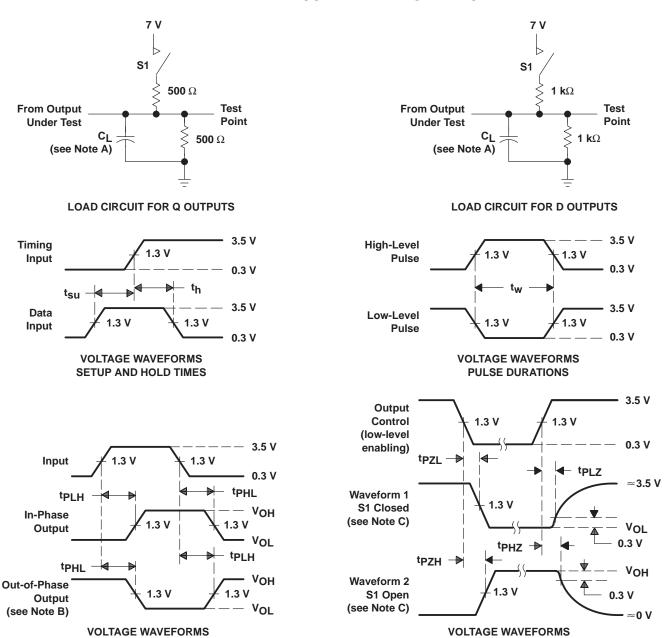
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 4.5 C <sub>L</sub> = 50 pF T <sub>A</sub> = MIN to	UNIT	
			MIN	MAX	
<sup>t</sup> PLH	D		3	14	
<sup>t</sup> PHL	ט	Q	4	16	ns
<sup>t</sup> PLH	LE		6	20	ne
<sup>t</sup> PHL	LL	Q	8	25	ns
<b>4</b>	HL CLR Q D	Q	6	20	
<sup>t</sup> PHL		D	8	26	ns
t <sub>en</sub> ‡		_	4	21	
t <sub>dis</sub> §	OERB	D	2	14	ns
t <sub>en</sub> ‡	<del></del> <del>O</del> EQ	0	4	18	
t <sub>dis</sub> §	OEQ	Q	1	14	ns

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

<sup>‡</sup>t<sub>en</sub> = t<sub>PZH</sub> or t<sub>PZL</sub> §t<sub>dis</sub> = t<sub>PHZ</sub> or t<sub>PLZ</sub>

**ENABLE AND DISABLE TIMES, 3-STATE OUTPUTS** 

#### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

PROPAGATION DELAY TIMES

- B. When measuring propagation delay times of 3-state outputs, switch S1 is open.
- C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- D. All input pulses have the following characteristics:  $PRR \le 1$  MHz,  $t_r = t_f = 2$  ns, duty cycle = 50%.

Figure 1. Load Circuits and Voltage Waveforms



www.ti.com 11-Nov-2025

#### PACKAGING INFORMATION

Orderable part number	Status (1)	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
SN74ALS992DW	Active	Production	SOIC (DW)   24	25   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	ALS992
SN74ALS992DW.A	Active	Production	SOIC (DW)   24	25   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	ALS992

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

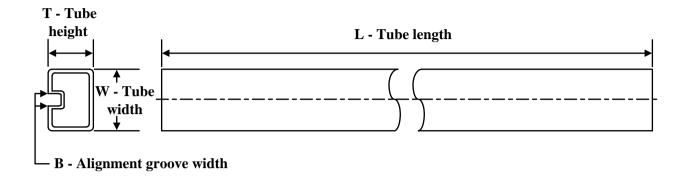
<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

# **PACKAGE MATERIALS INFORMATION**

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### **TUBE**

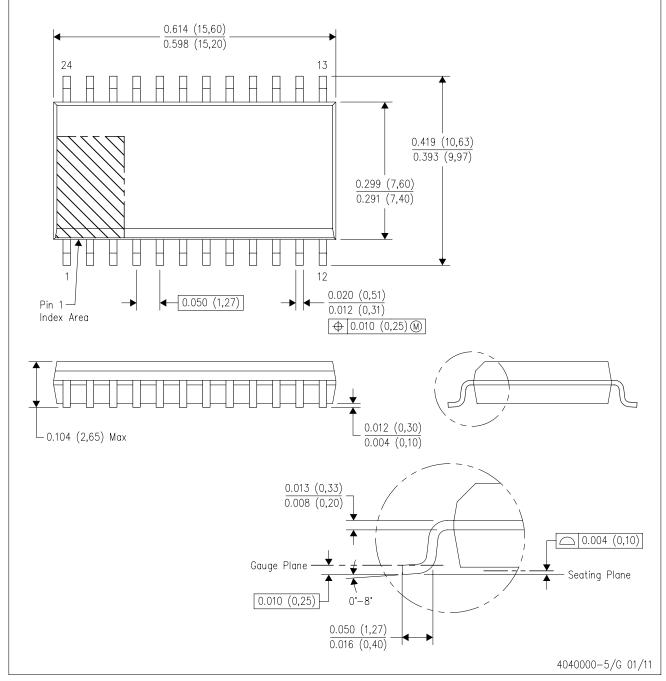


#### \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
SN74ALS992DW	DW	SOIC	24	25	506.98	12.7	4826	6.6
SN74ALS992DW.A	DW	SOIC	24	25	506.98	12.7	4826	6.6

DW (R-PDSO-G24)

### PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AD.



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